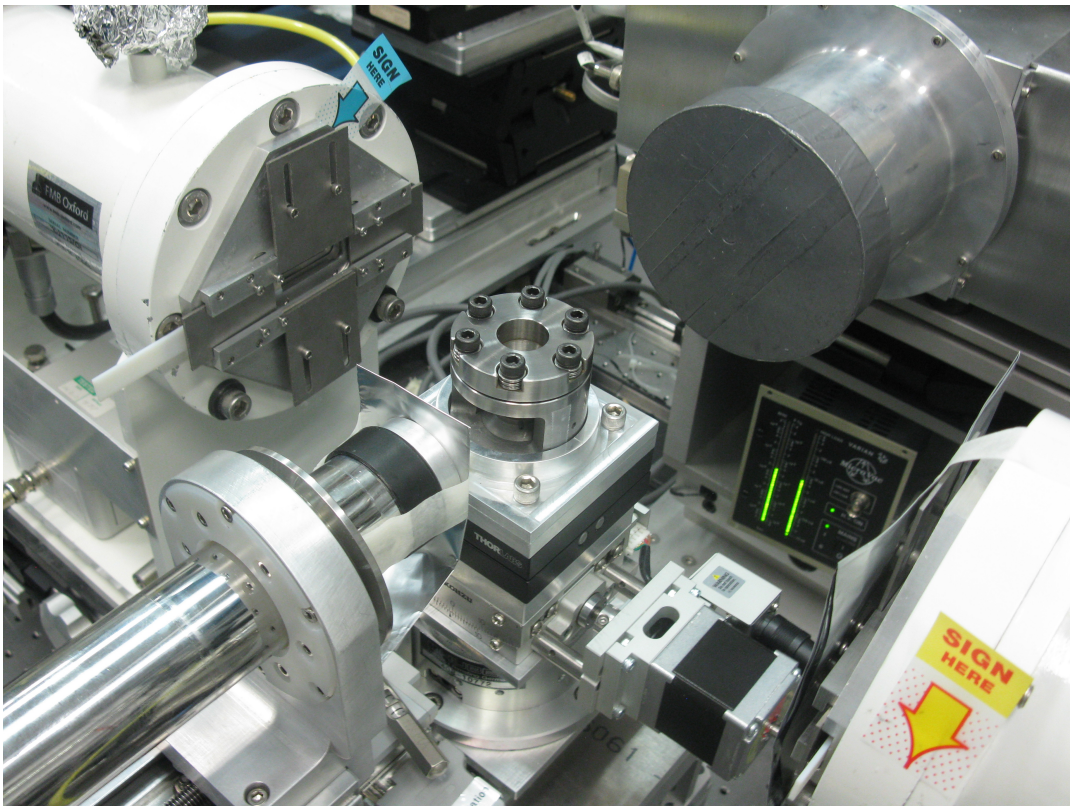
HXMA high pressure XAFS

Beamline: HXMA

Contact: Ning Chen

A setup under development at HXMA to measure x-ray absorption spectroscopy under high pressure. The setup has adapters to accommodate several types of diamond anvil cells (DACs). Users supply the DACs. Combined XAFS and x-ray diffraction measurement capability is planned.